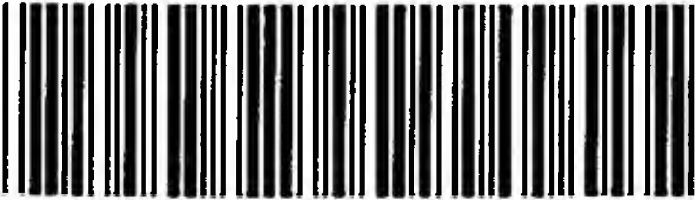


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/710,894	HOU ET AL.	
	Examiner	Art Unit	
	Minh Nguyen	2816	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB), See printout	11/8/2005	MN
Limited search (327/147-151,156-160, 39-49, 375/373-376, 331/1A,40, dig.2, 369/30.27,47.4), see printout	11/8/2005	MN